



DMN3022LDG

30V SYNCHRONOUS N-CHANNEL ENHANCEMENT MODE MOSFET PowerDI3333-8 (Type D)

Product Summary

Device	BV _{DSS}	R _{DS(ON)} Max
Q1	30V	$22m\Omega$ @ $V_{GS} = 5V$, $I_D = 10A$
Q2	30V	$8m\Omega$ @ $V_{GS} = 5V$, $I_D = 10A$

Features and Benefits

- 100% Unclamped Inductive Switch (UIS) Test in Production
- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Lead-Free Finish; RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

Description and Applications

This new generation MOSFET is designed to minimize the on-state resistance (R_{DS(ON)}) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

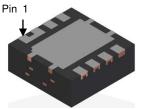
PowerDI3333-8 (Type D)

- DC-DC Converters
- Power Management Functions
- Analog Switch

Mechanical Data

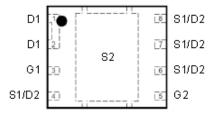
- Case: PowerDI[®]3333-8 (Type D)
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Matte Tin Annealed over Copper Leadframe.
 Solderable per MIL-STD-202, Method 208 ⁽³⁾
- Weight: 0.044 grams (Approximate)





Top View

Bottom View



Top View Pin Configuration

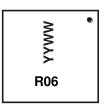
Ordering Information (Note 4)

Part Number	Case	Packaging
DMN3022LDG-7	PowerDI3333-8 (Type D)	1,000/Tape & Reel
DMN3022LDG-13	PowerDI3333-8 (Type D)	3,000/Tape & Reel

Notes:

- 1. EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant. All applicable RoHS exemptions applied.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/

Marking Information



R06 = Product Type Marking Code YYWW = Date Code Marking YY = Last Two Digits of Year (ex: 18 = 2018) WW = Week Code (01 to 53)



Maximum Ratings (@ $T_A = +25$ °C, unless otherwise specified.)

Characteristic	Symbol	Q1	Q2	Unit	
Drain-Source Voltage		V_{DSS}	30		V
Gate-Source Voltage	V _{GSS}	±10		V	
Continuous Dunin Comment QV 5V	$T_C = +25$ °C $T_C = +70$ °C	I _D	15 12		Α
Continuous Drain Current @ V _{GS} = 5V	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I _D	7.6 6.1		А
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%)		I _{DM}	50	100	Α
Avalanche Current (Note 6) L = 0.1mH		I _{AS}	24	43	Α
Avalanche Energy (Note 6) L = 0.1mH		Eas	28	92	mJ

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Unit	
Total Power Dissipation	$T_A = +25^{\circ}C$	ם	1.96	W	
Total Fower Dissipation	$T_A = +70$ °C	P_{D}	1.25		
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	ר	64		
mermai nesistance, junction to Ambient (Note 5)	t < 10s	$R_{\theta JA}$	36	°C/W	
Thermal Resistance, Junction to Case (Note 5)		$R_{ heta JC}$	8.7		
Operating and Storage Temperature Range		T _{J,} T _{STG}	-55 to +150	°C	

Electrical Characteristics Q1 (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)						
Drain-Source Breakdown Voltage	BV _{DSS}	30	-	_	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current	I _{DSS}	_	_	1	μΑ	$V_{DS} = 20V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	$V_{GS} = \pm 10V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)						
Gate Threshold Voltage	V _{GS(TH)}	1	1.4	2.1	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
Static Drain-Source On-Resistance	R _{DS(ON)}	1	16	22	mΩ	$V_{GS} = 5V, I_D = 10A$
Forward Transfer Admittance	Y _{FS}	_	17	_	S	$V_{DS} = 5V, I_{D} = 8A$
Diode Forward Voltage	V _{SD}	_	0.84	1	V	$V_{GS} = 0V, I_S = 8A$
DYNAMIC CHARACTERISTICS (Note 8)						
Input Capacitance	C _{iss}	_	370	481		V _{DS} = 15V, V _{GS} = 0V, f = 1.0MHz
Output Capacitance	Coss	_	176	228	pF	
Reverse Transfer Capacitance	C_{rss}	_	8.2	10.6		
Gate Resistance	R_{G}	_	2.5	6.5	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$
Total Gate Charge (V _{GS} = 4.5V)	Q_{G}	_	2.8	3.7		
Total Gate Charge at V _{TH}	Q _{G(TH)}	_	0.35	_	nC	151/ 1 0 0
Gate-Source Charge	Q _{GS}	_	0.6	_	IIC	$V_{DS} = 15V, I_{D} = 8A$
Gate-Drain Charge	Q_{GD}	_	0.5	_		
Turn-On Delay Time	t _{D(ON)}	_	4.5	6.7		$V_{DD} = 15V, V_{GS} = 4.5V,$ $I_{D} = 8A, R_{G} = 2\Omega$
Turn-On Rise Time	t _R	_	1.8			
Turn-Off Delay Time	t _{D(OFF)}	_	7.2	10.8	ns	
Turn-Off Fall Time	t _F	_	1.9			
Reverse Recovery Time	t _{RR}	_	11.5	_	ns	
Reverse Recovery Charge	Q _{RR}	-	6.9	-	nC	$I_F = 8A$, di/dt = 300A/ μ s

Notes:

- 5. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
- 6. I_{AS} and E_{AS} ratings are based on low frequency and duty cycles to keep T_{J} = +25°C.
- 7. Short duration pulse test used to minimize self-heating effect.
- 8. Guaranteed by design. Not subject to product testing.

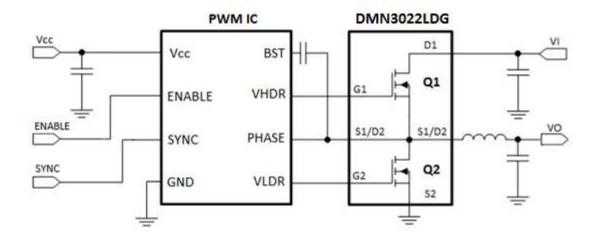


Electrical Characteristics Q2 (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)							
Drain-Source Breakdown Voltage	BV _{DSS}	30	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current T _J = +25°C	I _{DSS}	_	_	1.0	μA	$V_{DS} = 20V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	$V_{GS} = \pm 10V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	V _{GS(TH)}	0.8	0.96	1.2	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	
Static Drain-Source On-Resistance	R _{DS(ON)}	_	6.4	8	mΩ	$V_{GS} = 5V, I_D = 10A$	
Forward Transfer Admittance	Y _{FS}	_	33	_	S	$V_{DS} = 5V, I_{D} = 8A$	
Diode Forward Voltage	V_{SD}	_	0.78	1	V	$V_{GS} = 0V, I_{S} = 8A$	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	C _{iss}	_	766	996	pF	V _{DS} = 15V, V _{GS} = 0V, f = 1.0MHz	
Output Capacitance	Coss	_	441	573	pF		
Reverse Transfer Capacitance	Crss	_	19	25	pF		
Gate Resistance	R _G	_	0.69	1.5	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1MHz$	
Total Gate Charge (V _{GS} = 4.5V)	Q_{G}	_	6.1	8	nC		
Total Gate Charge at V _{TH}	Q _{G(TH)}	_	0.47	_	nC	V 15V I 9A	
Gate-Source Charge	Q _{GS}	_	0.8	_	nC	$V_{DS} = 15V, I_D = 8A$	
Gate-Drain Charge	Q _{GD}	_	1.1	_	nC		
Turn-On Delay Time	t _{D(ON)}	_	5.6	8.4	ns	$V_{DD} = 15V, V_{GS} = 4.5V,$ $I_{D} = 8A, R_{G} = 2\Omega$	
Turn-On Rise Time	t _R	_	2.5	_	ns		
Turn-Off Delay Time	t _{D(OFF)}	_	11.7	17.5	ns		
Turn-Off Fall Time	t _F		2.4		ns		
Reverse Recovery Time	t _{RR}	_	27.9	_	ns	-I _F = 8A, di/dt = 300A/μs	
Reverse Recovery Charge	Q _{RR}	_	9.9	_	nC		

7. Short duration pulse test used to minimize self-heating effect. 8. Guaranteed by design. Not subject to product testing. Notes:

Typical Circuit





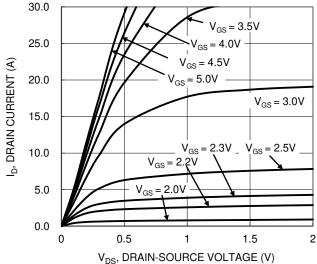


Figure 1. Q1 Typical Output Characteristic

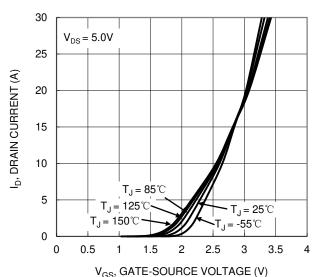


Figure 3. Q1 Typical Transfer Characteristic

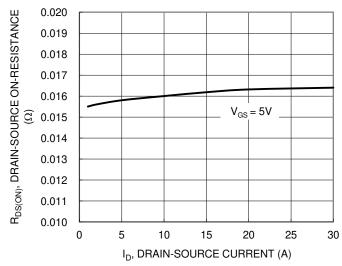
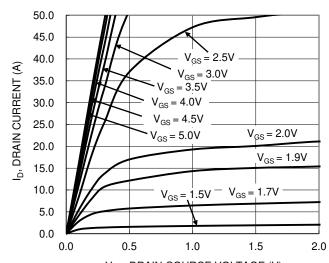


Figure 5. Q1 Typical On-Resistance vs. Drain Current and Gate Voltage



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m V_{DS}}, {
m DRAIN}\mbox{-SOURCE VOLTAGE (V)}$ Figure 2. Q2 Typical Output Characteristic

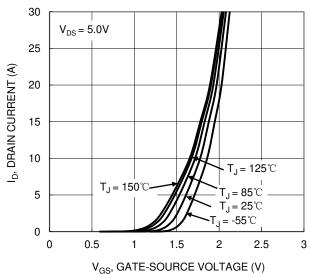


Figure 4. Q2 Typical Transfer Characteristic

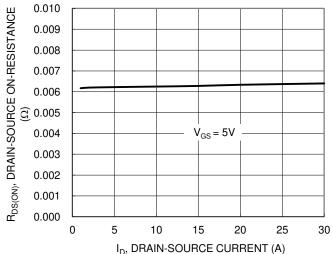
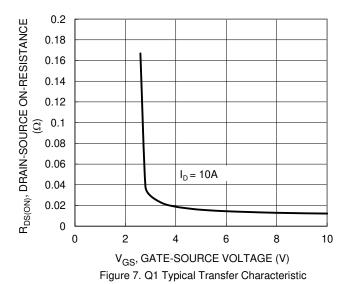


Figure 6. Q2 Typical On-Resistance vs. Drain Current and Gate Voltage







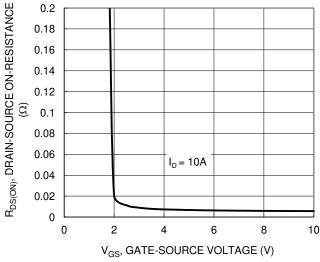
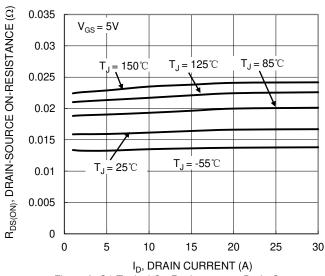
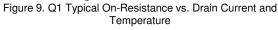


Figure 8. Q2 Typical Transfer Characteristic





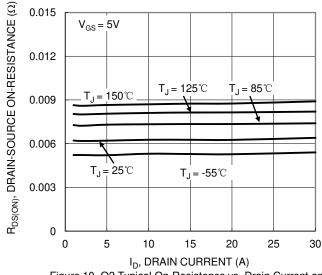


Figure 10. Q2 Typical On-Resistance vs. Drain Current and Temperature

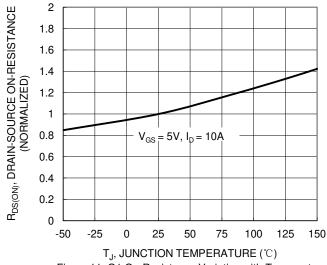


Figure 11. Q1 On-Resistance Variation with Temperature

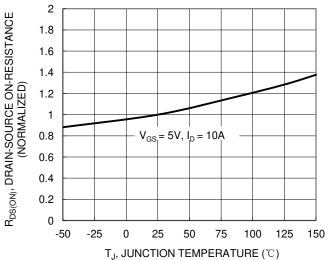


Figure 12. Q2 On-Resistance Variation with Temperature





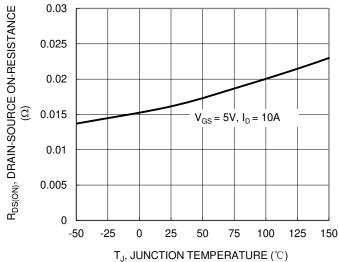


Figure 13. Q1 On-Resistance Variation with Temperature

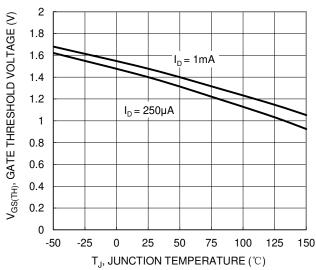


Figure 15. Q1 Gate Threshold Variation vs. Junction Temperature

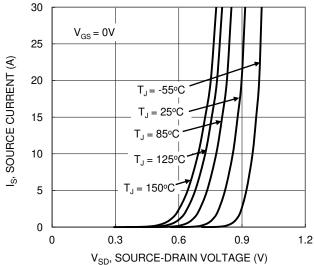


Figure 17. Q1 Diode Forward Voltage vs. Current

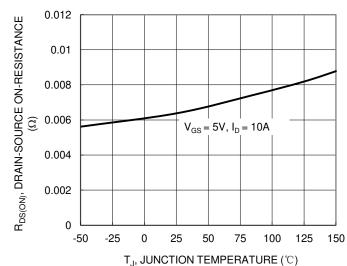


Figure 14. Q2 On-Resistance Variation with Temperature

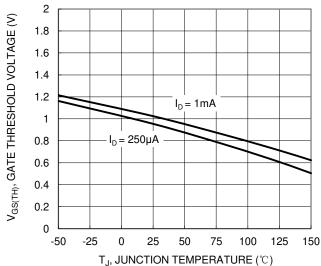
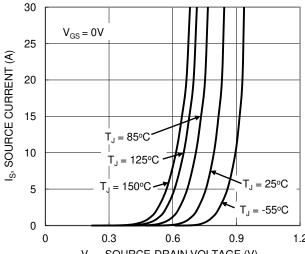


Figure 16. Q2 Gate Threshold Variation vs. Junction Temperature



 $\rm V_{SD},\,SOURCE\text{-}DRAIN\,VOLTAGE\,(V)$ Figure 18. Q2 Diode Forward Voltage vs. Current



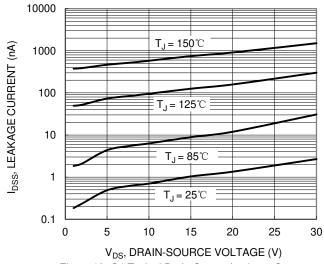


Figure 19. Q1 Typical Drain-Source Leakage Current vs. Voltage

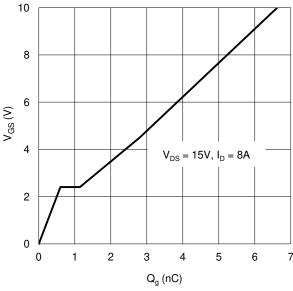
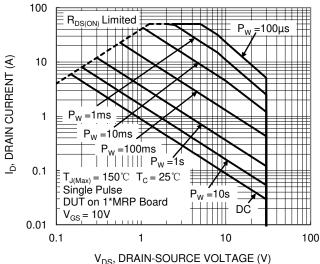


Figure 21. Q1 Gate Charge



V_{DS}, DRAIN-SOURCE VOLTAGE (V) Figure 23. Q1 SOA, Safe Operation Area

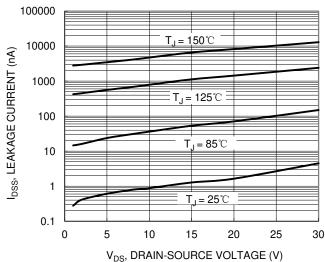


Figure 20. Q2 Typical Drain-Source Leakage Current vs.

Voltage

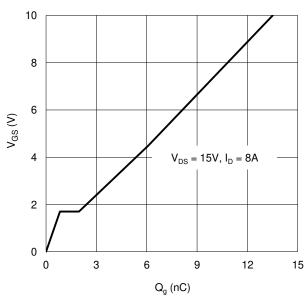
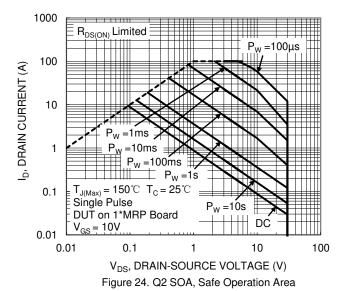


Figure 22. Q2 Gate Charge





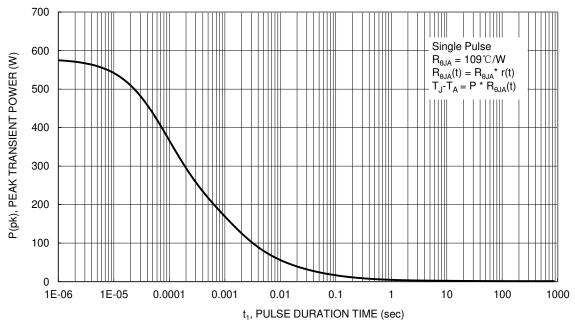


Figure 25. Single Pulse Maximum Power Dissipation

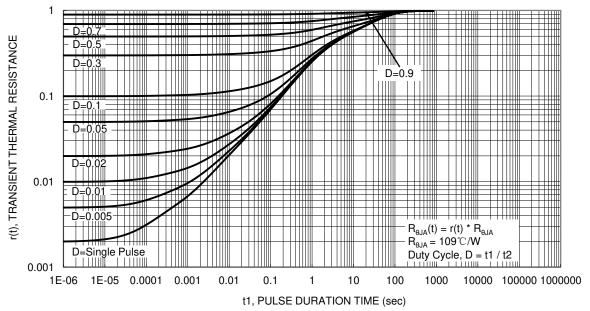


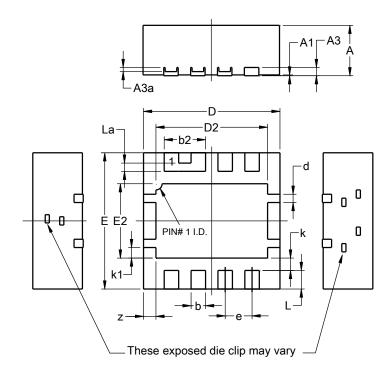
Figure 26. Transient Thermal Resistance



Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

PowerDI3333-8 (Type D)

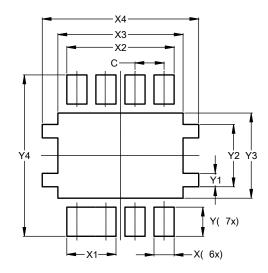


PowerDI3333-8						
(Type D)						
Dim	Min	Min Max Typ				
Α	1.17	1.23	1.20			
A 1	0.00	0.05	0.02			
A3	0.15	0.25	0.20			
A3a	0.05	0.15	0.10			
b	0.30	0.40	0.35			
b2	0.95	1.05	1.00			
D	3.20	3.40	3.30			
D2	2.65	2.75	2.70			
Е	3.20	3.40	3.30			
E2	1.75	1.85	1.80			
d	0.15	0.25	0.20			
е	-		0.65			
k			0.30			
k1	0.21	0.31	0.26			
L	0.40	0.50	0.45			
La	0.15	0.25	0.20			
Z	0.25	0.35	0.30			
All Dimensions in mm						

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

PowerDI3333-8 (Type D)



Dimensions	Value			
HILISIONS	(in mm)			
С	0.650			
X	0.450			
X1	1.100			
X2	2.400			
Х3	2.800			
X4	3.500			
Υ	0.650			
Y1	0.300			
Y2	1.390			
Y3	1.900			
Y4	3.600			



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